1200 V SiC MPS<sup>™</sup> Diode

### Silicon Carbide Power **Schottky Diode**

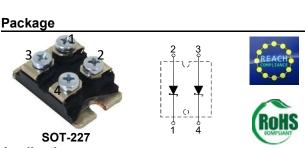
### Features

- High Avalanche (UIS) Capability
- Enhanced Surge Current Capability
- 175 °C Maximum Operating Temperature
- Temperature Independent Switching Behavior
- Positive Temperature Coefficient Of V<sub>F</sub>
- Extremely Fast Switching Speeds
- Superior Figure of Merit Q<sub>C</sub>/I<sub>F</sub>

### **Advantages**

- Low Standby Power Losses
- Improved Circuit Efficiency (Lower Overall Cost)
- Low Switching Losses
- Ease of Paralleling Devices without Thermal Runaway
- Smaller Heat Sink Requirements
- Low Reverse Recovery Current
- Low Device Capacitance
- Low Reverse Leakage Current at Operating Temperature

### **Absolute Maximum Ratings**



Qc

F (Tc = 132°C)

#### Applications

- Power Factor Correction (PFC)
- Switched-Mode Power Supply (SMPS)
- Solar Inverters
- Wind Turbine Inverters
- Motor Drives
- Induction Heating
- Uninterruptible Power Supply (UPS)
- High Voltage Multipliers

Parameter	Symbol	Conditions	Values	Unit V	
Repetitive Peak Reverse Voltage (Per Leg)	V <sub>RRM</sub>		1200		
Continuous Forward Current (Per Leg/Per Device)	I <sub>F</sub>	T <sub>C</sub> = 25 °C, D = 1 T <sub>C</sub> = 132 °C, D = 1	102/204 50/100	А	
J J J J J J J J J J J J J J J J J J J		$T_{C}$ = 25 °C, $t_{P}$ = 10 ms $T_{C}$ = 150 °C, $t_{P}$ = 10 ms	320 280	А	
Repetitive Peak Forward Surge Current, Half Sine Wave (Per Leg)	I <sub>F,RM</sub>	$T_{C}$ = 25 °C, t <sub>P</sub> = 10 ms $T_{C}$ = 150 °C, t <sub>P</sub> = 10 ms	220 150	А	
Non-Repetitive Peak Forward Surge Current (Per Leg)	$I_{F,max}$	$T_{C}$ = 25 °C, $t_{P}$ = 10 µs	1400	А	
l <sup>²</sup> t Value (Per Leg)	∫i² dt	T <sub>C</sub> = 25 °C, t <sub>P</sub> = 10 ms	300	A <sup>2</sup> s	
Non-Repetitive Avalanche Energy (Per Leg)	E <sub>AS</sub>	$L = 1 \text{ mH}, I_{AV} = 42 \text{ A}, V_{DD} = 60 \text{ V}$	450	mJ	
Diode Ruggedness (Per Leg)	dV/dt	V <sub>R</sub> = 0 ~ 960 V	100	V/µs	
Power Dissipation (Per Leg/Per Device)	P <sub>tot</sub>	T <sub>C</sub> = 25 °C	380/760	W	
Operating and Storage Temperature	T <sub>i</sub> , T <sub>stg</sub>		-55 to 175	°C	

### **Electrical Characteristics (Per Leg)**

Parameter	Cumph of	Conditions –		Values		Unit	
Parameter	Symbol			min.	typ.	max.	Unit
Diode Forward Voltage	V <sub>F</sub>	I <sub>F</sub> = 50 A, T <sub>j</sub> = 25 °C		1.5	1.8	V	
Didde i di ward voltage	vF	I <sub>F</sub> = 50 A, T <sub>j</sub> = 175 °C			2.3	2.7	v
Reverse Current	1	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 25 °C		5	70	μA	
	I <sub>R</sub>	V <sub>R</sub> = 1200 V, T <sub>j</sub> = 175 °C			40		475
Total Capacitive Charge	Q <sub>c</sub>		V <sub>R</sub> = 400 V		186		nC
	QC	$ I_F \leq  I_{F,MAX} $	V <sub>R</sub> = 800 V		277		
Switching Time	4	dl <sub>F</sub> /dt = 200 A/µs T₁ = 175 °C	V <sub>R</sub> = 400 V		< 10		ns
	ts	.,	V <sub>R</sub> = 800 V				115
Total Canacitanaa	С	V <sub>R</sub> = 1 V, f = 1 MHz, T <sub>j</sub> = 25 °C		3037		ъĘ	
Total Capacitance		V <sub>R</sub> = 800 V, f = 1 MH:	<sub>R</sub> = 800 V, f = 1 MHz, T <sub>j</sub> = 25 °C		203		pF

#### Thermal / Mechanical Characteristics

Thermal Resistance, Junction – Case (Per Leg)	R <sub>thJC</sub>	0.39	°C/W
* Per Device, ** Per Leg			



=

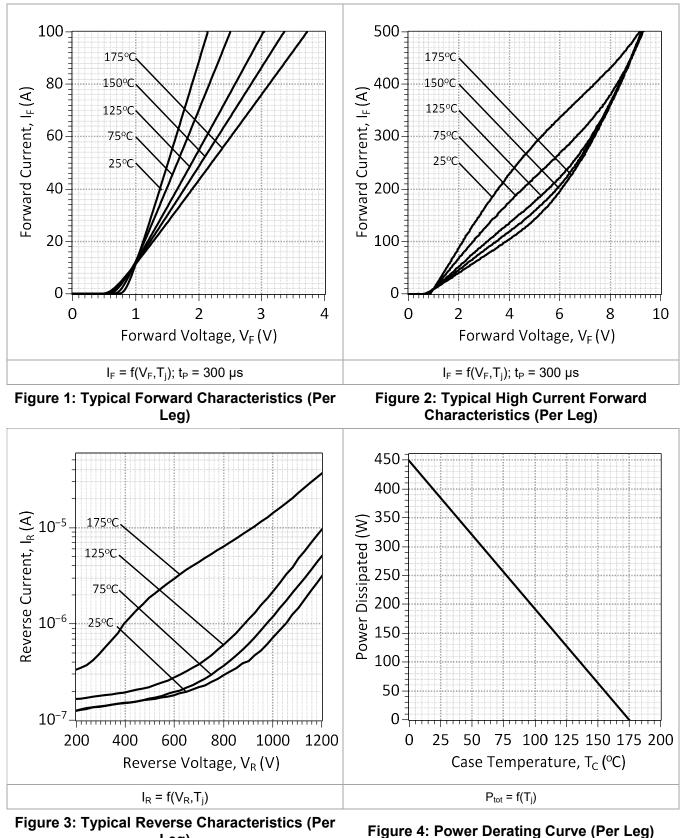
2 3	REACH

100 A\*

554 nC\*



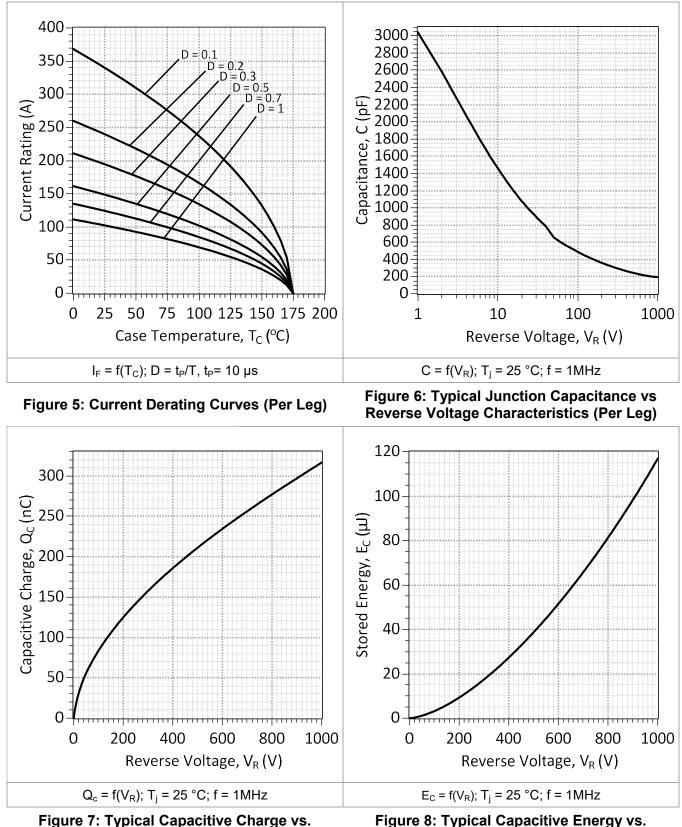




Leg)



1200 V SiC MPS<sup>™</sup> Diode

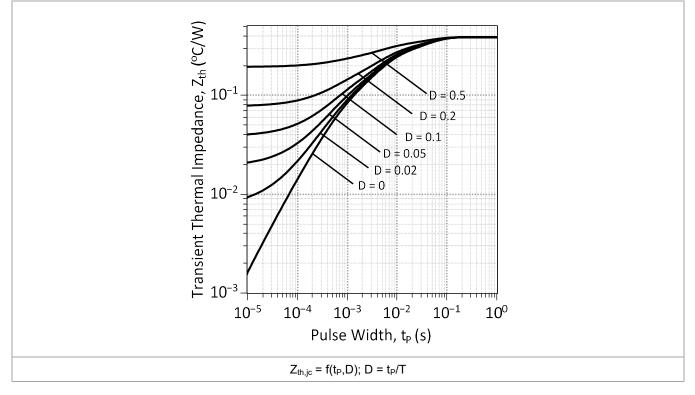


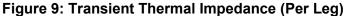
Reverse Voltage Characteristics (Per Leg)

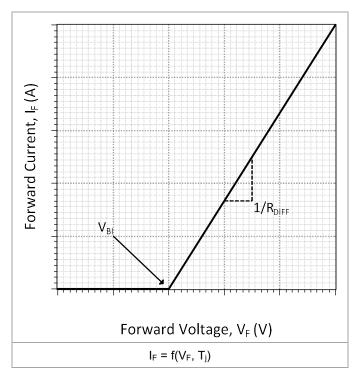
Figure 8: Typical Capacitive Energy vs. Reverse Voltage Characteristics (Per Leg)

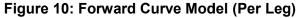


1200 V SiC MPS<sup>™</sup> Diode









 $I_F = (V_F - V_{BI})/R_{DIFF}$ 

Built-In Voltage (V<sub>BI</sub>):

 $V_{BI}(T_j) = m^*T_j + b,$ m = -1.29e-03, b = 0.913

**Differential Resistance (R<sub>DIFF</sub>):**  $R_{DIFF}(T_j) = a^*T_j^2 + b^*T_j + c (\Omega);$ a = 6.10e-05, b = 9.01e-03, c = 2.01

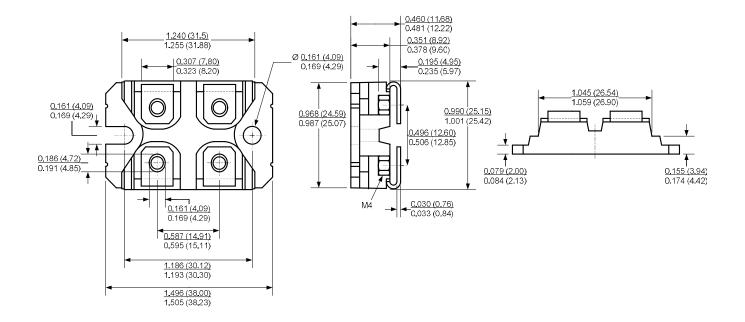


### Package Dimensions:

SOT-227



### PACKAGE OUTLINE



#### NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.

2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS



1200 V SiC MPS<sup>™</sup> Diode

### **RoHS Compliance**



The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your GeneSiC representative.

### **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control systems.

GeneSiC disclaims all and any warranty and liability arising out of use or application of any product. No license, express or implied to any intellectual property rights is granted by this document.

### **Related Links**

- Soldering Document: http://www.genesicsemi.com/quality/quality-manual/
- Tin-whisker Report: http://www.genesicsemi.com/quality/compliance/
- Reliability Report: http://www.genesicsemi.com/quality/reliability/



Feb 2018

**Rev1.1** 

Copyright © 2018 GeneSiC Semiconductor Inc. All Rights Reserved The information in this document is subject to change without notice Published by GeneSiC Semiconductor, Inc. 43670 Trade Center Place Suite 155 Dulles, VA 20166

1200 V SiC MPS<sup>™</sup> Diode





This is a secure document. Please copy this code from the SPICE model PDF file on our website (http://www.genesicsemi.com/sic\_rectifiers\_diodes/merged\_pin\_schottky/GB2X50MPS12-227\_SPICE.pdf) into LTSPICE (version 4) software for simulation of the GB2X50MPS12-227. All the simulations are per leg.

			r SiC MPS <sup>TM</sup> F	Rectifier	
* Revis	ion: 1.	1			
* Date:	Februa	ry-2018			
******	******	******	*****	***************************************	
**		7 package			
*******	******	*******	*****	***************************************	
.SUBCKT GB2	2X50MPS1				
			10n		
D1			GC50MPS12		
L_cathode	K	Case	10n		
.ends					
				***************************************	
.SUBCKT GB2	2X50MPS1	L2 ANODE	KATHODE		
D1 ANODE KA					
.MODEL GC50			D		
+ IS	4.27E-1	_ 4	RS	0.0124	
	1		IKF	500	
+ EG			XTI	2	
+ TRS1	0.00543	34	TRS2	2.717E-05	
+ CJO	4.24E-1	_ 0	VJ	0.879	
+ M	0.438		FC	0.5	
+ TT	1.00E-1	_ 0	BV	1600	
+ IBV	5E-06		VPK	1200	
+ IAVE	50		TYPE	SiC_MPS <sup>™</sup>	
+ MFG	GeneSiC	C_Semi			
.ENDS					
* End of GE	32X50MPS	512 <b>-</b> 227 S	PICE Model		
*******	******	*******	*******	***************	
* This model is provided "AS IS, WHERE IS, AND WITH NO WARRANTY OF ANY KIND					

This model is provided "AS IS, WHERE IS, AND WITH NO WARRANTY OF ANY KIND

\* EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED TO ANY IMPLIED

\* WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE."

